

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10605944	BOUDON ET AL.
	Examiner	Art Unit
	Wai, Eric C	2195

SEARCHED

Class	Subclass	Date	Examiner
718	100	07/09/2007	ECW

SEARCH NOTES

Search Notes	Date	Examiner
Inventor's Name Search	07/09/2007	ECW
East Search	07/09/2007	ECW

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner